Issue (Classii	fication

Applica	tion/Contro	ol No.

10/066,095 Examiner

Brandon W. Bowers

Applicant	s)/Patent	unde
Reexamin	ation	

TEIG ET AL.

2825

ISSUE CLASSIFICATION												
ORIGINAL		CROSS REFERENCE(S)										
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
716 12	716	13	19									
INTERNATIONAL CLASSIFICATION												
60 C F 17 / 50												
2 (Assistant Examiner) (Date	/12/05) ,	Gut	TW MU THE SIEK	ت	Total Claims: Allowed: 20							
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	Claims renumbered in the same order as presented by applicant						☐ CPA			☐ T.D.			☐ R.1.47						
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